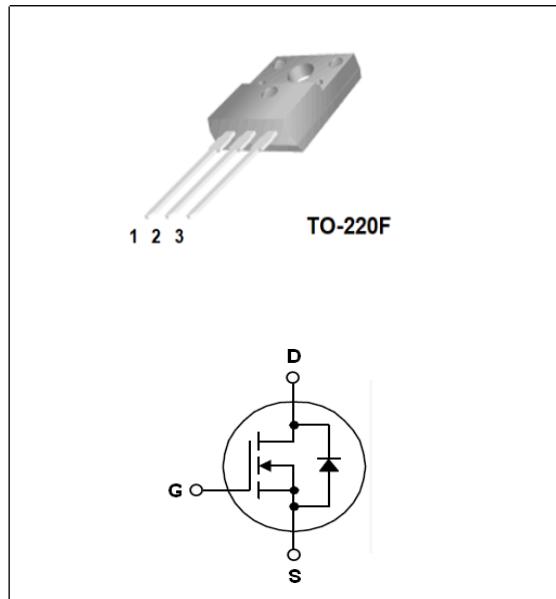


650V 12A N-Channel Enhancement Mode Power MOSFET

Description

The AKT12N65F is an N-Channel enhancement mode power MOSFET which using proprietary planar stripe and DMOS technology.

This MOSFET has low static on-resistance and high avalanche energy strength. This device provide excellent switching performance for UPS,DC-DC converters and AC-DC power supply.



Features

- Low on-Resistance: $R_{DS(on)}=0.64\Omega(\text{typ.})$
- Special Process Technology for high ESD Capability
- 100% Avalanche Test
- Good Stability and Uniformity with High E_{AS}

Applications

- UPS Applications
- DC-DC Converters and AC-DC Power Supply

Absolute Maximum Ratings @ $T_C=25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | | Ratings | Unit |
|-----------|--------------------------------------|-------------------------|----------|---------------------|
| V_{DSS} | Drain to Source Voltage | | 650 | V |
| V_{GSS} | Gate to Source Voltage | | ± 30 | V |
| I_D | Drain Current | $T_C=25^\circ\text{C}$ | 12 | A |
| | | $T_C=100^\circ\text{C}$ | 7.5 | A |
| I_{DM} | Pulsed Drain Current | (Note1) | 48 | A |
| P_D | Maximum Power Dissipation | $T_C=25^\circ\text{C}$ | 70 | W |
| | Derate above 25°C | | 0.56 | W/ $^\circ\text{C}$ |
| E_{AS} | Single Pulsed Avalanche Energy | (Note 2) | 550 | mJ |
| T_J | Operating Junction Temperature Range | | -55~+150 | $^\circ\text{C}$ |
| T_{STG} | Storage Temperature Range | | -55~+150 | $^\circ\text{C}$ |

Thermal Characteristics

| Symbol | Parameter | Ratings | Unit |
|---------------|---|---------|---------------------------|
| $R_{th(J-C)}$ | Thermal Resistance, Junction to case | 1.78 | $^\circ\text{C}/\text{W}$ |
| $R_{th(J-A)}$ | Thermal Resistance, Junction to Ambient | 62.5 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics @ $T_C=25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|--------------------------|-----------------------------------|---|------|------|-----------|---------------|
| BV_{DSS} | Drain to Source Breakdown Voltage | $V_{\text{GS}}=0\text{V}, I_D=250\mu\text{A}$ | 650 | - | - | V |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$ | 2.0 | - | 4.0 | V |
| $R_{\text{DS(on)}}$ | Static Drain-Source On-Resistance | $V_{\text{GS}}=10\text{V}, I_D=6\text{A}$ | - | 0.64 | 0.8 | Ω |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{\text{DS}}=650\text{V}, V_{\text{GS}}=0\text{V}$ | - | - | 1 | μA |
| I_{GSS} | Gate to Source Leakage Current | $V_{\text{GS}}=\pm 30\text{V}, V_{\text{DS}}=0\text{V}$ | - | - | ± 100 | nA |

D-S Diode Characteristics and Maximum Rating @ $T_C=25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|-----------------|---|---|------|------|------|---------------|
| I_S | Maximum Drain to Source Diode Forward Current | | - | - | 12 | A |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{\text{GS}}=0\text{V}, I_S=12\text{A}$ | - | 0.9 | 1.4 | V |
| t_{rr} | Reverse Recovery Time | | - | 568 | - | ns |
| Q_{rr} | Reverse Recovery Charge | $V_{\text{GS}}=0\text{V}, I_S=12\text{A}, \frac{dI}{dt}=-100\text{A}/\text{us}$ | - | 5.5 | - | μC |

Switching Characteristics @ $T_C=25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|---------------------|------------------------------|---|------|------|------|------|
| $t_{\text{d(on)}}$ | Turn-on Delay Time | $I_D=12\text{A}, V_{\text{DD}}=325\text{V}, R_G=25\Omega$ (Note 3) | - | 30 | - | ns |
| t_r | Rising Time | | - | 115 | - | ns |
| $t_{\text{d(off)}}$ | Turn-off Delay Time | | - | 95 | - | ns |
| t_f | Falling Time | | - | 85 | - | ns |
| C_{iss} | Input Capacitance | $V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, f=1.0\text{MHz}$ | - | 1480 | - | pF |
| C_{oss} | Output Capacitance | | - | 200 | - | pF |
| C_{rss} | Reverse Transfer Capacitance | | - | 25 | - | pF |
| Q_g | Total Gate Charge | $I_D=12\text{A}, V_{\text{DS}}=520\text{V}$ $V_{\text{GS}}=10\text{V}$ (Note 3) | - | 43 | - | nC |
| Q_{gs} | Gate to Source Charge | | - | 8.6 | - | nC |
| Q_{gd} | Gate to Drain Charge | | - | 20.5 | - | nC |

Note:

1. Repetitive rating: pulse-width limited by maximum junction temperature
2. $L=2\text{mH}, V_{\text{DD}}=100\text{V}, V_{\text{G}}=10\text{V}, @T_C=25\text{ }^\circ\text{C}$
3. Essentially independent of operating temperature typical characteristics

Typical Performance Characteristics

Fig. 1. Typical on-Region Characteristics

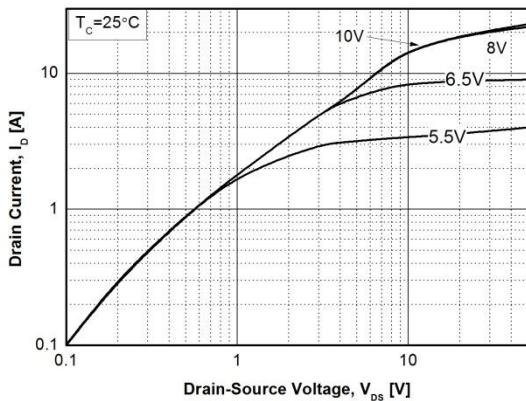


Fig. 3. Static on-Resistance vs. I_D

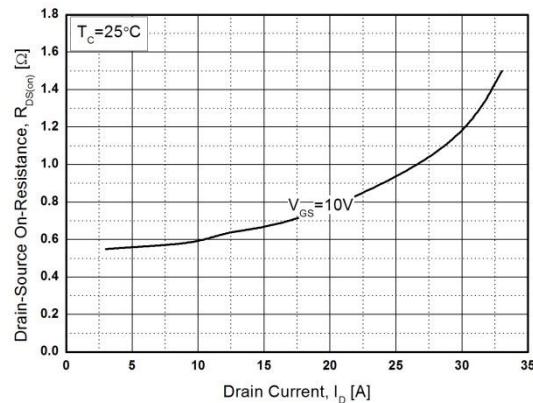


Fig. 5. Capacitance Characteristics

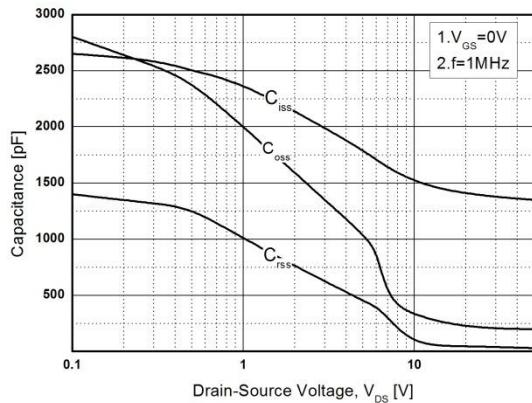


Fig. 2. Typical Transfer Characteristics

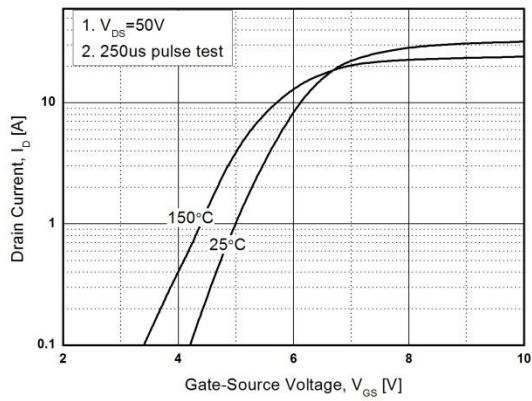


Fig. 4. Body Diode Forward Voltage vs. I_{DR}

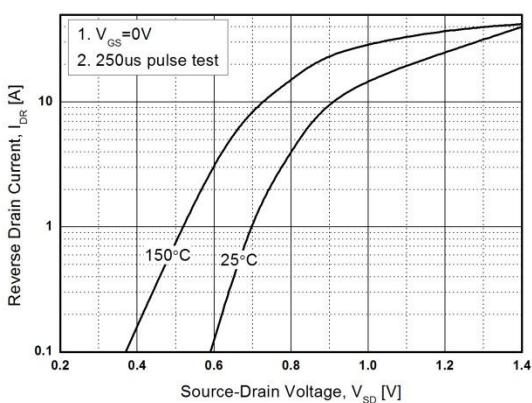
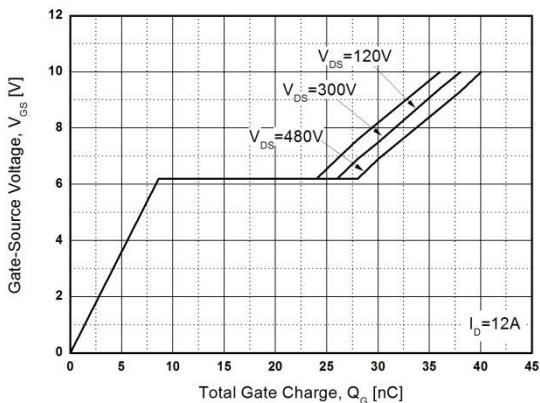


Fig. 6. Gate Charge Characteristics



Typical Performance Characteristics

Fig. 7. Breakdown Voltage vs. Temperature

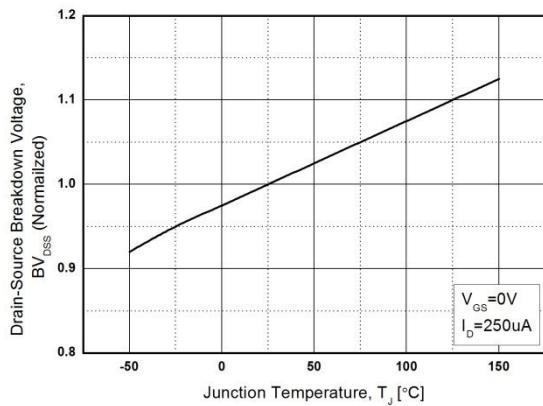


Fig. 8. Static on-Resistance vs. Temperature

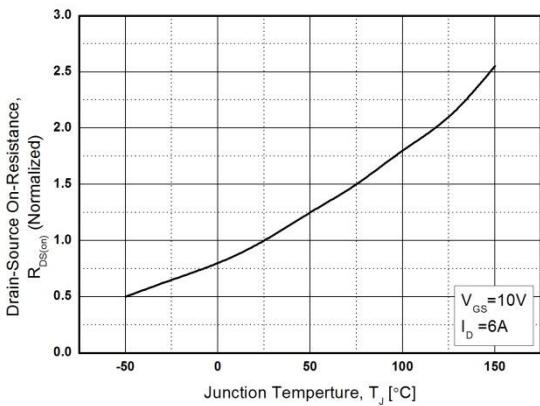


Fig. 9. Maximum Safe Operating Area

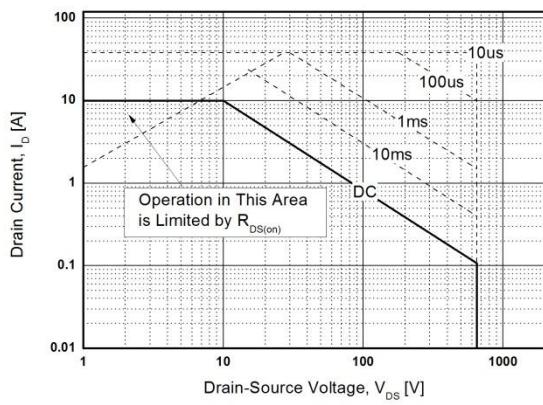


Fig. 10. Maximum Drain Current vs. Temperature

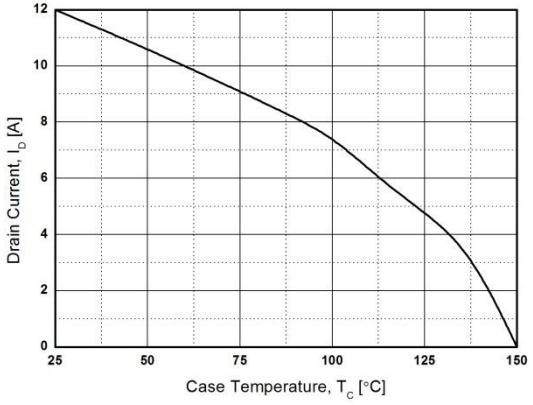
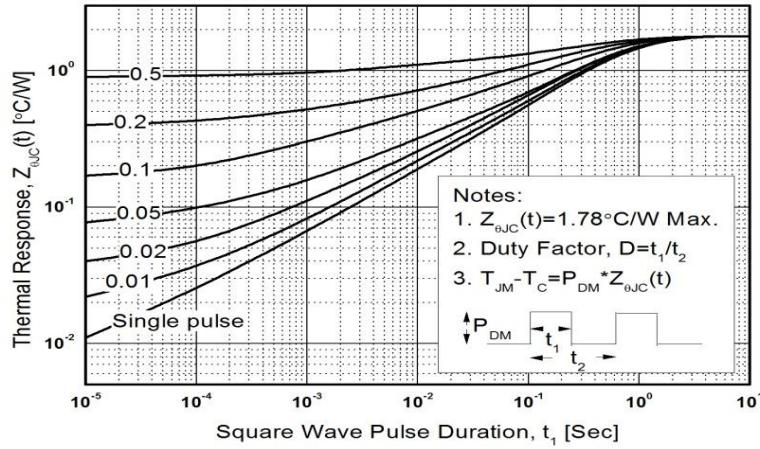


Fig. 11. Transient Thermal Response Curve



Package Dimensions**TO-220F**

(Dimensions in Millimeters)

